COMSOL CONFERENCE 2019

Impact of Operating Parameters on Precursor Separation in "Air Hockey" Spatial Atomic Layer Deposition Reactor

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SCHOOL OF ENGINEERING

Introduction: Atomic Layer Deposition (ALD)

What is ALD?

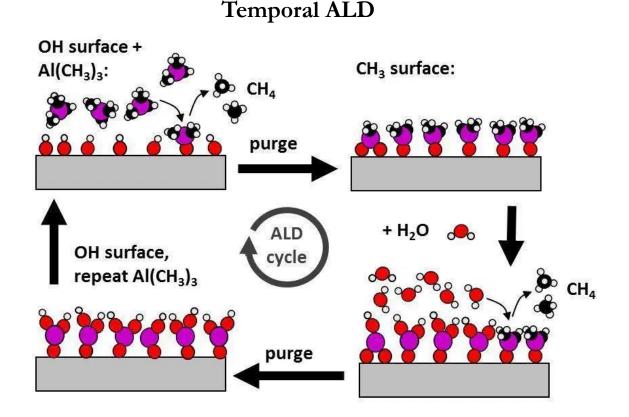
 Thin film deposition technique praised for high quality, conformal, dense films with atomic level thickness control

Critical Features:

- Sequential exposure of surface to saturating precursors
- Low growth rates (0.1 nm/s)
- Vacuum process

Applications:

- Semiconductors
- Solar Cells
- Optical Filters





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Introduction: Spatial ALD

Why Spatial ALD?

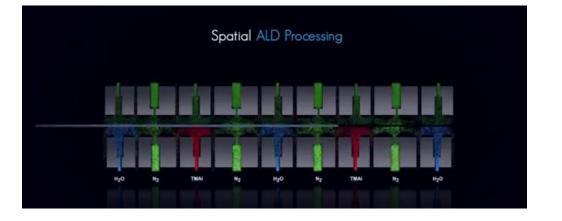
- Ultra-fast, uniform thin films deposited at low temperatures
- Industrially viable, high-throughput processing

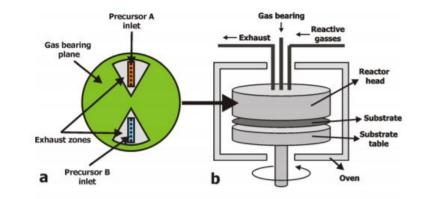
Critical Feature of Spatial ALD Reactors:

Successful spatial separation of the precursors

Types of Spatial ALD Reactors:

- Roll-to-Roll (Flexible Substrates)
- In-line deposition head (Sheet-to-Sheet)
- Rotary stage (Batch Processing)







Overview: Air Hockey Reactor

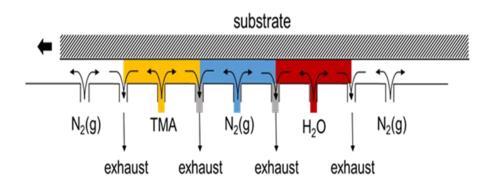
Operation:

- The vents in the deposition region suspend the substrate on a bed of fluid
- Precursor separation is achieved through a barrier gas stream placed between the precursor vents
- Atmospheric pressure operation

Challenges:

- The deposition gap is a function of the flow parameters
- Deposition gap is critical to prevent precursor mixing

$$Mg = \int_0^R 2\pi r(\boldsymbol{p} - p_a) dr$$



Motivation and Approach:

- Develop a model to predict the flotation height
- Investigate how different operating conditions affect precursor separation and utilization

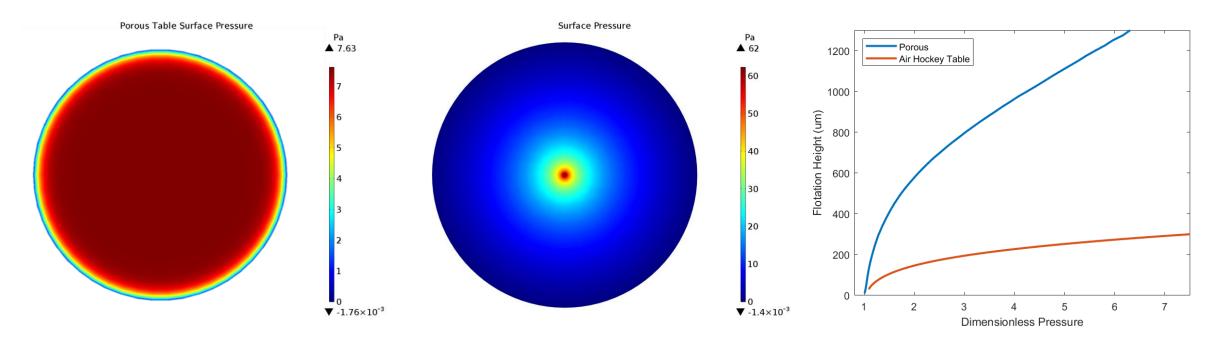


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Part I: Flotation Height



Summary – Poster Session



Hypothesis: The air hockey table will behave according to the porous table model at the limit of an infinitely sized array with infinitely small vertical jets

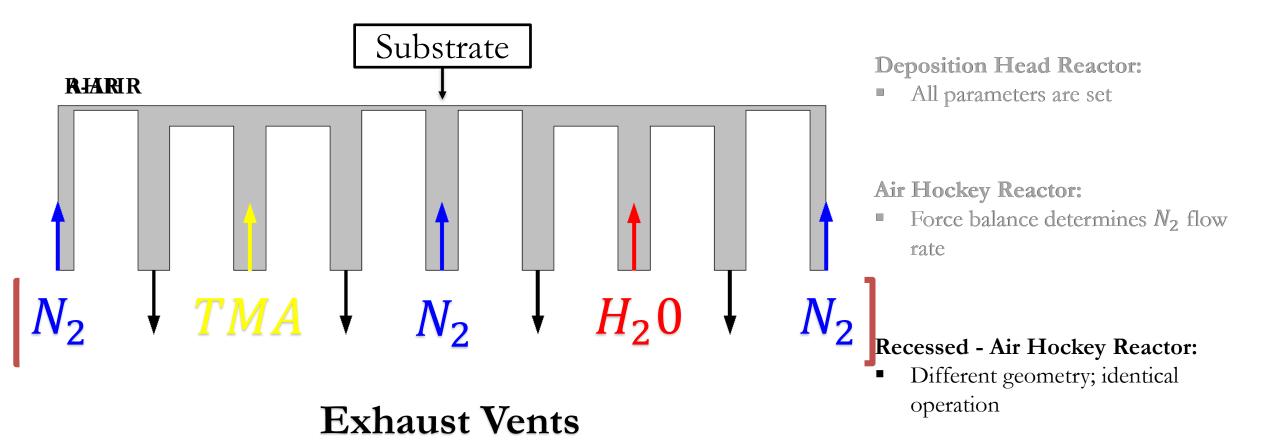
Visit my Poster - Thursday 6:00-7:00PM for more detailed information



Part II: Diffusion Model



Diffusion Model Definition





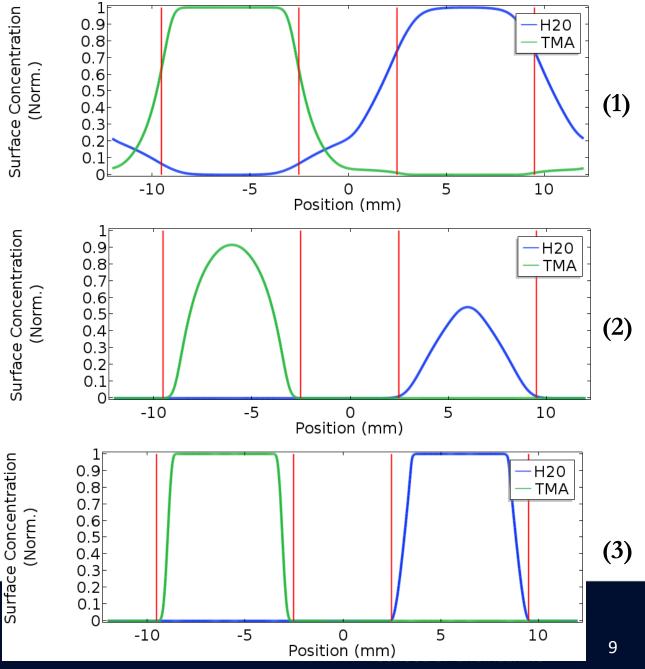
Regimes of Operation (1) **CVD Regime:** • Precursor mixing occurs in overlap region

(2) Precursor Deficient Regime

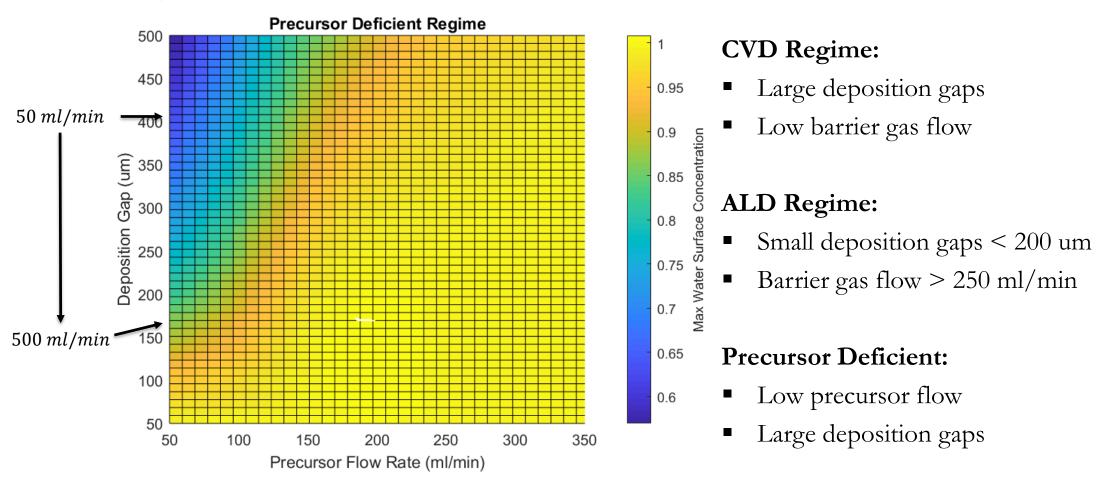
- Nonuniform surface concentration
- Insufficient precursor utilization

(3) ALD Regime:

- Effective precursor separation
- High surface concetration



Deposition Head Reactor (DHR)





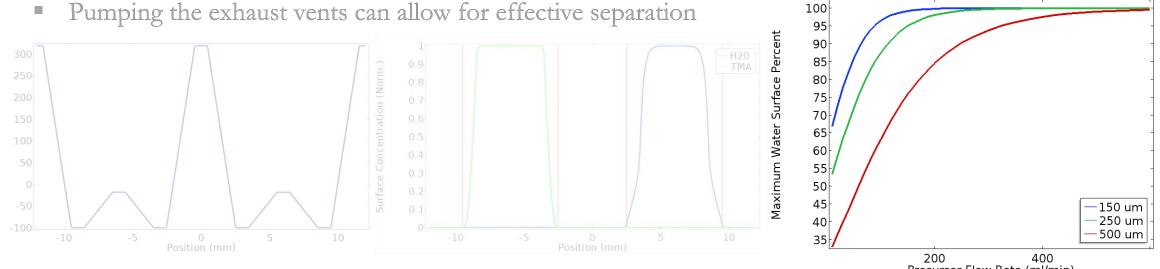
Air Hockey Reactor (AHR)

Small Deposition Gaps (50 um):

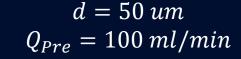
- Effective precursor separation at all conditions except small deposition gaps
- *Q*_{Precursor} > *Q*_{Barrier}

Precursor Deficiency:

Sensitive to deposition height and precursor flow rate



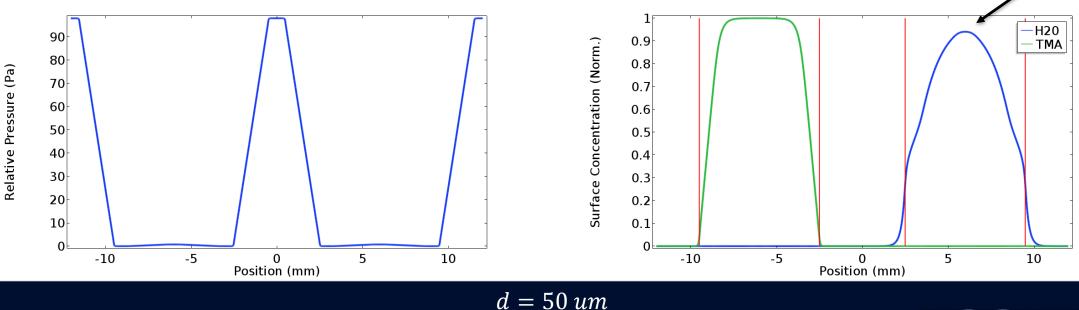
Precursor Flow Rate (ml/min)

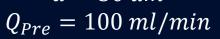




Recessed – Air Hockey Reactor (R-AHR)

- Identical Operation to AHR with improved ALD regime in small deposition gap
- The recessed region diminishes the force contribution from the precursor flow
 - Effect increases with increasing depth
- Tradeoff is low precursor surface concentration, greater barrier gas flow





 H_20 Surface

Loss

Part III: Precursor Utilization



Defining Precursor Utilization

- Diffusion model alone does not adequately quantify precursor efficiency
- The surface reaction consumes precursor during operation

 $F_{IN} = F_{OUT} + F_{rxn}$

Define precursor utilization based on unreacted precursor

 $\eta_A = \left(1 - \frac{F_{OUT}}{F_{IN}}\right) x 100$

Is it possible to define a stationary model to quantify precursor utilization?

What is it missing?

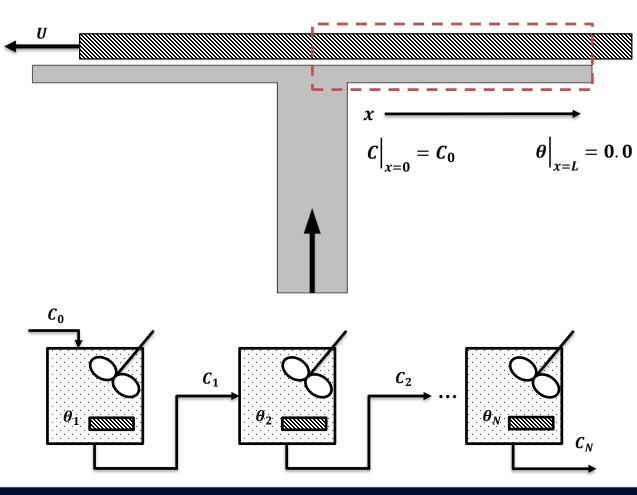
- 1. Precursor adsorption surface reaction
 - Surface limited reaction
- 2. Substrate translational motion
 - Introduction of unreacted surface
- 3. Time dependency

$$R_A(t,x) = k_{ads} s_0 (1 - \theta_A(t,x)) C_A$$

 $R_A \equiv Surface Reaction Rate$ $k_{ads} \equiv Adsorption Rate Constant$ $s_0 \equiv Sticking Coefficient$ $\theta_A \equiv Surface Coverage of A$ $C_A \equiv Bulk Concentration of A$



Proposed Stationary Method



Method:

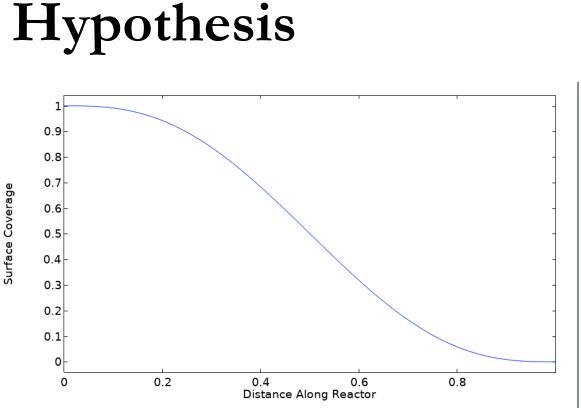
- Simulate space-dependent model with global model of large N CSTR in series
- Map time domain to space domain for surface coverage

$$\begin{aligned} \theta_{ads}(t,x) &\Rightarrow \theta_{ads}(x) \\ R_A(t,x) &\Rightarrow R_A(x) \end{aligned}$$

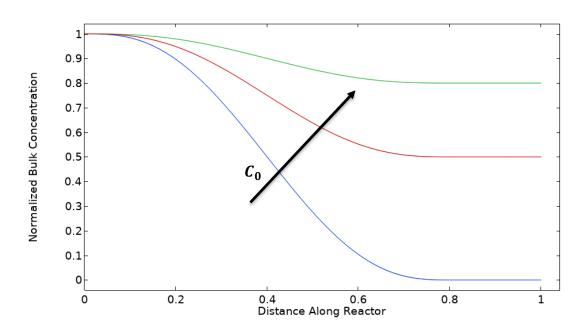
- Solve space-dependent transport of species and laminar flow interfaces
- Calculate precursor efficiency



CSTR in Series



- Each set of initial conditions will result in a different expression for $\theta(x)$
- This will adjust the reaction rate and solve for concentration



- If the initial concentration is too high, all unreacted precursor will leave through the outlet
 - Lowers precursor utilization
- Increasing deposition gap



Conclusions/Future Work

Conclusions:

- DHR: Both CVD and ALD Regimes
- AHR: Sensitive to process parameters at low deposition gaps
- R-AHR: Diminishes precursor force contribution, tradeoff with surface concentration
- Without surface reactions, precursor utilization can not be determined
- Current focus is on improvement of precursor efficiency

Future Work:

- Experimentally validate operating regimes through stationary deposition
- Quantitatively compare reactor type efficiency
- Use computational study as baseline for scaling air hockey table spatial ALD reactor



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